


Search Notes 	Application/Control No. 10585604	Applicant(s)/Patent Under Reexamination DOBKIN ET AL.
	Examiner SHEELA C CHAWAN	Art Unit 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	100, 115	6/6/09	SCC
726	22,23,25	6/6/09	SCC
705	4	6/6/09	SCC
340	5.26,426.25,5.64,5.72,825.69,628,690,428,518,521,511, 5.82	6/6/09	SCC
713	187,188,190	6/6/09	SCC
726	25, 22, 23 , 24	6/6/09	SCC
706	14	6/6/09	SCC
324	`178	"	"
307	10.2	"	"
380	262, 28	"	"
180	287	"	"
375	138	"	"
ABOVE SEARCH UP-DATE.		"	"
382	100, 115	6/6/09	SCC
726	22	6/6/09	SCC
706	14	6/6/09	SCC
340	5.82, 426.25	6/6/09	SCC
ABOVE SEARCH UP-DATE.		6/6/09	SCC

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE , SEE THE SEARCH HISTORY.	6/6/09	SCC
382/100., 115 . ccls. US-PATENT TEXT SEARCH ONLY.	"	"
726/22,23,25.ccls. US-PATENT TEXT SEARCH ONLY.	6/6/09	SCC
340/5.26,426.25,5.64,5.72,825.69,628,690,428,518,521,511, 5.82.ccls. US-PATENT TEXT SEARCH ONLY.	"	"
706/14.CCLS. US-PATENT TEXT SEARCH ONLY.	"	"
324/138, CCLS. US-PATENT TEXT SEARCH ONLY	6/6/09	"
SEARCH INVENTOR NAME.	"	"
DISCUSS WITH SAMIR AHMED SPE ART UNIT 2624.	"	"

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SEARCH NOTES

Search Notes	Date	Examiner
INTERFERENCE SEARCH.	"	"
ABOVE SEARCH UP-DATE	"	"
SEARCH IEEE OR INSPEC DATA BASE.	"	"
ABOVE SEARCH UP-DATE	"	"

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
382	100, 115	6/6/09	SCC
726	22	6/6/09	SCC
706	14	6/6/09	SCC
340	426.25	6/6/09	SCC

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